

# **RZ/A2M Group**

### **ADC Driver**

#### Introduction

This application note describes the operation of the software ADC Driver for the RZ/A2 device on the RZ/A2M CPU Board.

It provides a comprehensive overview of the driver. For further details please refer to the software driver itself.

The user is assumed to have knowledge of e<sup>2</sup> studio and to be equipped with an RZ/A2M CPU Board.

#### **Target Device**

RZ/A2M Group

## **Driver Dependencies**

This driver depends on:

- Drivers
  - o STDIO
  - o INTC Driver
  - STB Driver
  - o GPIO Driver
  - o CBUFFER Driver

#### **Referenced Documents**

Document Type	Document Name	Document No.
User's Manual	RZ/A2M Hardware Manual	R01UH0746EJ
Application Note	RZ/A2M Smart Configurator User's Guide: e² studio	R20AN0583EJ
Application Note	OS Abstraction Middleware	R11AN0309EG

# **List of Abbreviations and Acronyms**

Abbreviation	Full Form		
ADC	Analogue to Digital Converter		
ANSI	American National Standards Institute		
API	Application Programming Interface		
ARM	Advanced RISC Machines		
CPU	Central Processing Unit		
GPIO	General Purpose Input Output		
HLD	High Layer Driver		
IDE	Integrated Development Environment		
INTC	INTerrupt Controller		
LLD	Low Layer Driver		
LSB	Least Significant Byte		
OS	Operating System		
STB	STandBy		
STDIO	Standard Input/Output		

Table 1-1 List of Abbreviations and Acronyms

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#### 1. Outline of the Software Driver

The ADC driver sequentially digitises the voltage level on up to eight input pins (AN000 to AN007) and can then interrupt the CPU to inform it that the conversions are complete. The conversion accuracy can be set to 8, 10, or 12-bit depending on whether speed or resolution is most important.

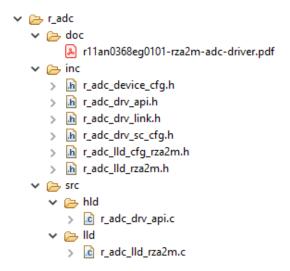
#### 2. Description of the Software Driver

The key features of the driver include selectable:

- Analogue input channels (up to 8)
- Resolution (8, 10, or 12-bit)
- Left or right data alignment
- Whether to block during the conversion scan, or invoke a callback function on completion
- Channel sample time

#### 2.1 Structure

The ADC driver is split into two parts: the High Layer Driver (HLD) and the Low Layer Driver (LLD). The HLD includes platform independent features of the driver, implemented via the STDIO standard functions. The LLD includes all the hardware specific functions.



# 2.2 Description of each file

Each file's description can be seen in the following table.

Filename	Usage	Description	
Application-Facing Driver API			
r_adc_drv_api.h	Application	The only API header file to include in application code	
	High La	yer Driver (HLD) Source	
r_adc_drv_api.c	Private (HLD only)	High Layer Driver (HLD) source code enabling the driver API	
		functions	
		ayer to Low Layer API	
r _adc_lld_xxxx.h	Private (HLD/LLD	Low Layer Driver (LLD) header file (where "xxxx" is a device	
	only)	and board-specific identification). Intended ONLY to provide	
		access for High Layer Driver (HLD) to required Low Layer	
		Driver functions (LLD). Not for use in application, not to	
		define any device specific enumerations or structures	
r_adc_lld_cfg_xxxx.h	Private (HLD/LLD	Low Layer Driver (LLD) header file (where "xxxx" is a device	
	only)	and board-specific identification). Intended for definitions of	
		device specific settings (in the form of enumerations and	
		structures). No LLD functions to be defined in this file	
		High and Low Layer Drivers (HLD/LLD Link)	
r_adc_drv_link.h	Private (HLD/LLD	Header file intended as an abstraction between low and high	
	only)	layer. This header will include the device specific	
	0	configuration file "r_adc_lld_xxxx.h"	
r_adc_device_cfg.h	Should be included	Header file intended as an abstraction between low and high	
	in	layer. This header will include the device specific	
	r_adc_drv_api.h"	configuration file "r_adc_lld_cfg_xxxx.h"	
n ada lld	Low Layer Driver (LLD) Source		
r_adc_lld_xxxx.c	Private (LLD only)	(Where "xxxx" is a device and board specific	
		identification). Provides the definitions for the Low Layer	
	Driver interface.		
r odo dru oo ofa b		mart Configurator	
r_adc_drv_sc_cfg.h	Private (HLD/LLD	This file is intended to be used by Smart Configurator to pass	
	only)	setup information to the driver. This is not for application use	

#### 2.3 Driver API

The driver can be either used through STDIO or through direct access. It is recommended not to mix both access methods.

The API functions can be seen in the table below:

Туре	Function	Arguments	Return Values	
int_t	adc_hld_open( st_stream_ptr_t p_stream )	[in] driver handle	>0: the handle to the driver DRV_ERROR Open failed	
	Driver initialisation interface is	mapped to open function		
	Called directly using the st_r_driver_t ADC driver handle g_adc_driver: i.e. g_adc_driver.open()			
void	adc_hld_close( st_stream_ptr_t p_stream )	[in] driver handle	None	
	Driver close interface is mappe	d to close function.		
	Called directly using the st_r_d g_adc_driver.close()	river_t ADC driver structure g_adc_	driver: i.e.	
int_t	adc_hld_read( st_stream_ptr_t p_stream, uint8_t *p_buffer, uint32_t count )	[in] driver handle [out] pointer to data buffer [in] the length of the buffer	The number of bytes read on success  DRV_ERROR Read failed	
	Driver read interface is mapped to the read function.			
	Reads ADC conversion data for enabled channels.			
	Called directly using the st_r_driver_t ADC driver structure g_adc_driver: i.e. g_adc_driver.read()			
The buffer length must be a multiple of the number of enabled channels a to contain each value (1 for 8-bit conversions, 2 for 10- and 12- bit conversions).				
int_t	adc_hld_control( st_stream_ptr_t p_stream, uint32_t ctl_code, void * p_ctl_struct	[in] driver handle [in] requested function code [in/out] dependent on ctl_code	DRV_SUCCESS Operation succeeded DRV_ERROR Operation failed	
	Driver control interface function.			
Maps to ANSI library low level control function.		control function.		
	Called directly using the st_r_driver_t ADC driver structure g_adc_driver: i.e. g_adc_driver.control()		driver: i.e.	
int_t	<pre>adc_get_version( st_stream_ptr_t p_stream, st_ver_info_ptr_t*p_ver_info )</pre>	[in] driver handle [out] pointer to version structure	DRV_SUCCESS Operation succeeded	
	Driver get_version interface function.			
	Maps to extended non-ANSI library low layer get_version function.			
	Called directly using the st_r_driver_t ADC driver structure g_adc_driver: i.e. g_adc_driver.get_version()			

#### 2.3.1 Operation

Due to the nature of the peripheral, the driver only supports a single thread and only one handle to it can be open at once. In a multi-threaded application where different threads need access to different ADC channels (inputs), then it is recommended to write an ADC manager thread to control the ADC and communicate conversion values to other threads within the application.

When the driver is opened, the ADC peripheral is initially configured using the settings in the ADC\_SC\_TABLE in the r\_adc/inc/r\_adc\_drv\_sc\_cfg.h header file. However, these settings can be changed by calling control (CTL ADC SET CONFIGURATION).

When the conversion is started by calling **control(CTL\_ADC\_SOFTWARE\_TRIGGER)**, the ADC performs a conversion scan, and converts each enabled channel. If a conversion complete callback has been configured, then the call to **control(CTL\_ADC\_SOFTWARE\_TRIGGER)** will return immediately, and the callback function will be invoked when the conversion scan completes. If a conversion complete callback has not been configured, then the **control(CTL\_ADC\_SOFTWARE\_TRIGGER)** call will block until the conversion scan is complete.

Please note that the conversion complete callback is called under interrupt context, and so should be written accordingly.

Conversion values are retrieved by calling **read()** and are returned in ascending channel order (AN000 → AN007) and only for enabled channels. The number of bytes returned for each conversion depends on the ADC resolution setting, so if it is set to 8-bits, then a single byte will be received for each one. Multi-byte conversion values are returned LSB first.

For example two channels are enabled (AN003 and AN006) and the conversion resolution is set to 10-bits. Each conversion value is thus 2 bytes long, and after calling **control(CTL\_ADC\_SOFTWARE\_TRIGGER)** and the conversion has completed, there will be 4 bytes returned by a call to **read()**.

Conversion values accumulate within the ADC driver conversion buffer, so if two conversion scans are performed before calling **read()**, in this example 8 bytes will be returned. The order will be AN003 first conversion, AN006 first conversion, AN006 second conversion.

In order to prevent misalignment issues with conversion data packets, the read() function must be called with a buffer length that is a multiple of the conversion packet size. It will return DRV\_ERROR if this is not the case. So in the above example with two channels enabled and 10-bit resolution the packet size is 4 bytes, and so the buffer length must be a multiple of 4.

## 3. Accessing the Driver

#### 3.1 STDIO

The Driver API can be accessed through the ANSI 'C' Library <stdio.h>, or directly. The following table details the operation of each function when used with the STDIO library:

Operation	Return	Function Details
open	gs_stdio_handle, unique handle to driver	open(DEVICE_IDENTIFIER "adc0", O_RDWR);
close	DRV_SUCCESS successful operation, or driver specific error	close(gs_stdio_handle);
read	The number of bytes read (>= 0) or DRV_ERROR on failure	read(gs_stdio_handle, buffer, buffer_length)
write	DRV_ERROR (write is not implemented in this ADC driver)	write(gs_stdio_handle, buffer, data_length)
control DRV_SUCCESS control was processed, or driver specific error		control(gs_stdio_handle, CTRL, &struct);
get_version DRV_SUCCESS drv_info was updated, or DRV_ERROR drv_info was not updated		get_version(DEVICE_IDENTIFIER "adc0", &drv_info);

#### 3.2 Direct

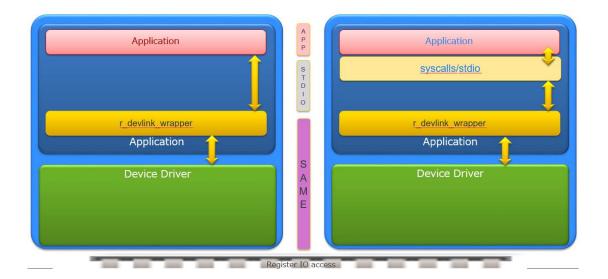
The following table shows the available direct functions.

Operation	Return	Function details
open	gs_direct_handle unique handle to driver	direct_open("adc0", 0);
close	DRV_SUCCESS successful operation, or driver specific error	direct_close(gs_direct_handle);
read	The number of bytes read (>= 0) or DRV_ERROR on failure	direct_read(gs_direct_handle, buff, data_length);
write	DRV_ERROR (write not implemented in this ADC driver)	direct_write(gs_direct_handle, buff, data_length);
control	DRV_SUCCESS control was processed, or driver specific error	direct_control(gs_direct_handle, CTRL, &struct);
get_version	DRV_SUCCESS drv_info was updated, or DRV_ERROR drv_info was not updated	direct_get_version("adc0", &drv_info);

## 3.3 Comparison

The diagram below illustrates the difference between the direct and ANSI STDIO methods.

Direct ANSI STDIO



#### 4. Example of Use

This section gives simple examples for opening the driver, setting the configuration, getting the configuration, software triggering a conversion scan, reading the conversion data, closing the driver, and finally getting the driver version.

#### 4.1 Open

```
int_t gs_adc_handle;
char_t *adc_drv_name = "\\\.\\adc0";

/* Note that the text "\\\.\" in the drive name signifies to the STDIO interface that the handle is to a peripheral and is not an access to a standard file-based structure */

gs_adc_handle = open(adc_drv_name, O_RDWR);
```

#### 4.2 Control – ADC Set Configuration

#### 4.3 Control – ADC Get Configuration

```
result = control(gs_adc_handle, CTL_ADC_GET_CONFIGURATION, (void *)
   &adc cfg);
```

#### 4.4 Control – ADC Software Trigger

```
result = control(gs_adc_handle, CTL_ADC_SOFTWARE_TRIGGER, NULL);
```

#### 4.5 Write

The stdio write() function is not supported by the ADC device driver.

#### 4.6 Read

```
uint8_t buffer[20];
int_t count;

count = read(gs_adc_handle, buffer, 20);
```

## 4.7 Close

close(gs\_adc\_handle);

## 4.8 Get Version

```
st_ver_info_t info;
result = get_version(gs_adc_handle, &info);
```

### 5. OS Support

This driver supports any OS through using the OS abstraction module. For more details about the abstraction module please refer to the OS abstraction middleware application note (R11AN0309EG).

## 6. How to Import the Driver

#### 6.1 e<sup>2</sup> studio

Please refer to the RZ/A2M Smart Configurator User's Guide: e² studio (R20AN0583EJ) for details on how to import drivers into projects in e2 studio using the Smart Configurator tool.

## 6.2 For Projects created outside e<sup>2</sup> studio

This section describes how to import the driver into your project. Generally, there are two steps in any IDE:

- 1) Copy the driver to the location in the source tree that you require for your project.
- 2) Add the link to where you copied your driver to the compiler.

Other required drivers, e.g. r\_cbuffer, must be imported similarly.



# **Revision History**

Description

Rev.	Date	Page	Summary
1.00	Mar.04.19	All	Created document.
1.01	May.08.19	All	Removed Low Layer Driver interface. Added section 6.1 for using driver in e <sup>2</sup> studio Updated template.

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  - The state of the product is undefined at the time when power is supplied. The states of internal circuits in the LSI are indeterminate and the states of register settings and pins are undefined at the time when power is supplied. In a finished product where the reset signal is applied to the external reset pin, the states of pins are not guaranteed from the time when power is supplied until the reset process is completed. In a similar way, the states of pins in a product that is reset by an on-chip power-on reset function are not guaranteed from the time when power is supplied until the power reaches the level at which resetting is specified.
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  - Do not input signals or an I/O pull-up power supply while the device is powered off. The current injection that results from input of such a signal or I/O pull-up power supply may cause malfunction and the abnormal current that passes in the device at this time may cause degradation of internal elements. Follow the guideline for input signal during power-off state as described in your product documentation.
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